Form PTO 1449	<del></del>	U.S. DEPARTMENT (	F COMMERCE	ATTY DOCKET NO.		SERIAL NO.		
(Modified)		PATENT AND TRAD	EMARK OFFICE	248232US2S		New Application		
		•		APPLICANT				
LIST OF	REFER	RENCES CITED BY API	PLICANT	Kazuyuki HIGASHI, et al.				
				FILING DATE		GROUP		
				Herewith				
U.S. PATENT DOCUMENTS								
EXAMINER		DOCUMENT	DATE		[ a. 4aa	SUB	FII	ING DATE
INITIAL		NUMBER	DATE	. NAME	CLASS	CLASS IF APPROPRIATE		
	AA							
	AB							
	AC							
	AD							
	AE							
	AF							
	AG							
	АН							
	AI							
	AJ							
	AK							
	AL						·	
	AM							
	AN	<del> </del>						
FOREIGN PATENT DOCUMENTS								
		DOCUMENT DATE COUNTRY			TRANSLATION			
		NUMBER	DATE	COUNTRY		YES		NO
	AO							
	AP							
	AQ							
	AR							
	AS							
	AT							
	ΑU							
	ΑV							
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW	Norio OKADA, et al., "THERMAL STRESS OF 140nm-WIDTH Cu DAMASCENE INTERCONNECTS", Proceedings of the International Interconnect Technology Conference, 2002, pgs. 136 - 138.						
	AX							
		· .						
	AY							
	AZ	Additional References sheet(s) at						sheet(s) attached
Examiner	/5 / S / S							31/05
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								